

Product data sheet

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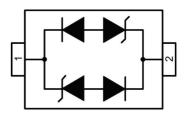
Features

- ♦ 350W peak pulse power (8/20µs)
- Ultra low capacitance : 1.0pF typical
- Ultra low leakage: nA level
- ◆ Low Operating: 3.3V,5V,8V,12V,15V,24V
- Low clamping voltage
- Protects one power line or data line
- Complies with following standards:
 - IEC 61000-4-2 (ESD) immunity test
 Air discharge: ±30kV
 Contact discharge: ±30kV
 - IEC61000-4-4 (EFT) 40A (5/50ns)
- RoHS Compliant

Mechanical Characteristics

- Package: SOD-323
- Lead Finish: Matte Tin
- Case Material: "Green" Molding Compound.
- UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 3 per J-STD-020
- Terminal Connections: See Diagram Below
- Marking Information: See Below





Circuit and Pin Schematic

SOD-323

Applications

- USB Ports
- Smart Phones
- Wireless Systems
- Ethernet 10/100/1000 Base T

Absolute Maximum Ratings (T_A=25°C unless otherwise specified)

Parameter	Symbol	Value	Unit	
ESD per IEC 61000-4-2 (Air)	VESD	±30	kV	
ESD per IEC 61000-4-2 (Contact)	VESD	±30	ΚV	
Operating Temperature Range	TJ	−40 to +85	°C	
Storage Temperature Range	Tstg	−55 to +150	°C	





Electrical Characteristics (T $_{\Delta}$ =25°C unless otherwise specified)

BV03C-MS								
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition		
Reverse Working Voltage	VRWM			3.3	V			
Breakdown Voltage	VBR	4			V	IT = 1mA		
Reverse Leakage Current	I _R		1	100	nA	VRWM = 3.3V		
Clamping Voltage	Vc			7	V	IPP = 1A (8 x 20µs pulse)		
Clamping Voltage	Vc			16	V	IPP = 20A (8 x 20µs pulse)		
Peak Pulse Current	IPP			20	А	tp=8/20µs		
Junction Capacitance	CJ		1		pF	VR = 0V, f = 1MHz		

BV05C-MS

			1	1		
Parameter	Symbol	Min	Тур	Мах	Unit	Test Condition
Reverse Working Voltage	VRWM			5	V	
Breakdown Voltage	VBR	6			V	IT = 1mA
Reverse Leakage Current	IR		1	100	nA	VRWM = 5V
Clamping Voltage	Vc			10	V	IPP = 1A (8 x 20µs pulse)
Clamping Voltage	Vc			18	V	IPP = 18A (8 x 20µs pulse)
Peak Pulse Current	IPP			18	А	tp=8/20µs
Junction Capacitance	Сл		1		pF	VR = 0V, f = 1MHz



BV08C-MS									
Parameter	Test Condition								
Reverse Working Voltage	VRWM			8	V				
Breakdown Voltage	VBR	8.5			V	IT = 1mA			
Reverse Leakage Current	I _R		1	100	nA	VRWM = 8V			
Clamping Voltage	Vc			14	V	IPP = 1A (8 x 20µs pulse)			
Clamping Voltage	Vc			19	V	IPP = 13A (8 x 20µs pulse)			
Peak Pulse Current	IPP			13	А	tp=8/20µs			
Junction Capacitance	CJ		1		pF	VR = 0V, f = 1MHz			

BV12C-MS

						1
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Reverse Working Voltage	VRWM			12	V	
Breakdown Voltage	VBR	13.3			V	IT = 1mA
Reverse Leakage Current	IR		1	100	nA	VRWM = 12V
Clamping Voltage	Vc			19	V	IPP = 1A (8 x 20µs pulse)
Clamping Voltage	Vc			25	V	IPP = 10A (8 x 20µs pulse)
Peak Pulse Current	IPP			10	A	tp=8/20µs
Junction Capacitance	CJ		1		pF	VR = 0V, f = 1MHz

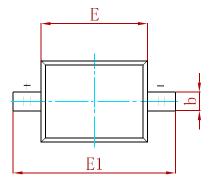


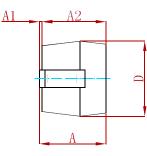
BV15C-MS								
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition		
Reverse Working Voltage	VRWM			15	V			
Breakdown Voltage	VBR	16.7			V	IT = 1mA		
Reverse Leakage Current	I _R		1	100	nA	VRWM = 15V		
Clamping Voltage	Vc			20	V	IPP = 1A (8 x 20µs pulse)		
Clamping Voltage	Vc			31	V	IPP = 8A (8 x 20µs pulse)		
Peak Pulse Current	IPP			8	А	tp=8/20µs		
Junction Capacitance	CJ		1		pF	VR = 0V, f = 1MHz		

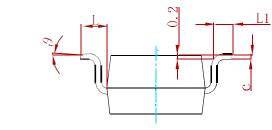
BV24C-MS								
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition		
Reverse Working Voltage	VRWM			24	V			
Breakdown Voltage	VBR	26.7			V	IT = 1mA		
Reverse Leakage Current	I _R		1	100	nA	VRWM = 24V		
Clamping Voltage	Vc			40	V	IPP = 1A (8 x 20µs pulse)		
Clamping Voltage	Vc			71	V	IPP = 3.5A (8 x 20µs pulse)		
Peak Pulse Current	IPP			3.5	A	tp=8/20µs		
Junction Capacitance	CJ		1		pF	VR = 0V, f = 1MHz		



PACKAGE MECHANICAL DATA

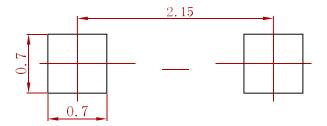






Cum h a l	Dimensions	In Millimeters	Dimension	s In Inches	
Symbol	Min.	Max.	Min.	Max.	
A		1.000		0.039	
A1	0.000	0.100	0.000	0.004	
A2	0.800	0.900	0.031	0.035	
b	0.250	0.350	0.010	0.014	
с	0.080	0.150	0.003	0.006	
D	1.200	1.400	0.047	0.055	
E	1.600	1.800	0.063	0.071	
E1	2.550	2.750	0.100	0.108	
L	0.475	REF.	0.019	REF.	
L1	0.250	0.400	0.010	0.016	
θ	0°	8°	0°	8°	

Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:±0.05mm

3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
BVXXC-MS	SOD-323	3000





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